

Amendments to the Claims

1. (CURRENTLY AMENDED) A power semiconductor device, comprising:
an output transistor (2) having main cells (32) and sense cells (34);
a control input (10) connected to the main and sense cells (32,34) and
main and sense cell controlled outputs (4,6,44,46);
an output terminal (12) connected to one of the main cell controlled
outputs for connection to a load (14);
a feedback circuit (36) for measuring the voltage across the main cell controlled
outputs of the output transistor and controlling the voltage on the control input (10) to increase
the voltage across the main cell controlled outputs if the magnitude of the voltage across the
controlled outputs (4,6) falls below a predetermined value;
a reference current supply (28) feeding a reference current through the sense cell
controlled outputs;
and a comparator (18) arranged to compare the voltages across the main cell outputs
(4,6) and the sense cell outputs (44,46) and to output a low-current signal when the magnitude of
the voltage across the main cell outputs (4,6) falls below that across the sense cell outputs
(44,46).

2. (CURRENTLY AMENDED) A power semiconductor device according to
claim 1 wherein the feedback circuit (36) includes a voltage reference (40) and a comparator (38)
connected across the main cell outputs (4,6) for comparing the voltage across the main cell
outputs with the voltage reference (40), the output of the comparator being connected through a
diode (42) to the control input, the diode being orientated to pass current to change the control
voltage in a direction to increase the on-resistance of the main cells (32) when the voltage across
the main cell outputs (4,6) falls below the predetermined value.

3. (CURRENTLY AMENDED) A power semiconductor transistor according to
~~claim 1 or 2~~
claim 1 wherein the main (32) and sense (34) cells are FET main and sense cells and
the gates (8,48) of the FETs are connected in common to the control input (10) and the sources
and drains (4,6,44,46) of the FETs of the main and sense cells form the outputs of the FETs.

4. (CURRENTLY AMENDED) A semiconductor device according to claim 3, in the form of a high side device wherein:

the drains (4, 44) of the sense and main cells are connected in common to a battery terminal (16);

the source (6) of the main cells is connected to the output terminal (12);

and

the source (46) of the sense cells is connected to the reference current (28)-supply, the reference current supply being a reference current sink.

5. (CURRENTLY AMENDED) A semiconductor circuit including a semiconductor device according to ~~any preceding claim~~claim 1 further comprising a load (14) connected to the output terminal (12).

6. (CURRENTLY AMENDED) A method of operating a semiconductor device, the device including an output transistor (2)-having main cells (32) and sense cells (34), and a control input (10)-connected to the main and sense cells and main and sense cell controlled outputs (4, 6, 44, 46), the method including:

driving the main and the sense cells (32, 34) in common;

driving a load from one of the main cell controlled outputs (16); feeding a reference current through the sense cell controlled outputs (44, 46);

measuring the voltage across the main cell controlled outputs (4, 6) and controlling the voltage on the control input (10)-to increase the voltage across the main cell controlled outputs (4, 6) if the magnitude of the voltage across the main cell controlled outputs (4, 6) falls below a predetermined value; and

comparing the voltages across the main cell controlled outputs (4, 6) and the sense cell controlled outputs (44, 46) and outputting a low-current

signal when the magnitude of the voltage across the main cell controlled outputs (4,
6) falls below that across the sense cell controlled outputs (44, 46).

7. (CURRENTLY AMENDED) A method according to claim 6 wherein the
step of measuring the

voltage across the main cell controlled outputs is performed by:

comparing the voltage across the main cell controlled outputs (4, 6)—with a
reference voltage (40) using a comparator (38); and

driving the control input (10) from the output of the comparator through a diode
(42), the diode being orientated to pass current to change the control input voltage in a
direction to increase the on-resistance of the main cells when the voltage across the main cell
outputs falls below the predetermined value.